## Application/Control No. 10/024,857 Applicant(s)/Patent Under Reexamination WALLACH ET AL. Examiner Thuy Pardo Applicant(s)/Patent Under Reexamination WALLACH ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,098,047	08-2000	Oku et al.	705/7
*	В	US-6,556,999	04-2003	Kloos et al.	707/10
*	C	US-6,708,057	03-2004	Morganroth, Joel	600/509
*	D	US-2003/0013951	01-2003	Stefanescu et al.	600/407
*	Ε	US-2003/0065669	04-2003	Kahn et al.	707/100
*	F	US-2003/0097077	05-2003	Morganroth, Joel	600/509
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
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	Р					
	Q	•				
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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